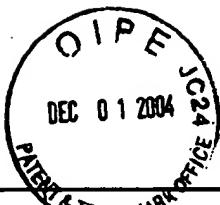


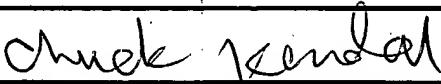
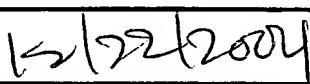
Please type a plus sign (+) inside this box →



PTO/SB/08A (08-00)

Substitute for form 1449B/PTO				<i>Complete if Known</i>	
<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b> <i>(use as many sheets as necessary)</i>					
Sheet	1	of	1	Attorney Docket Number	MTEC-007/00US

<b>OTHER PRIOR ART – NON PATENT LITERATURE DOCUMENTS</b>			
Examiner Initials*	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>2</sup>
	1	Embedded Trace Macrocell Specification, Rev. 0/0a, ARM IHI 0014C, ARM Ltd. (1999)	

Examiner Signature		Date Considered	
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<b>U.S. PATENT DOCUMENTS</b>					
Examiner Initials*	Cite No. <sup>1</sup>	U.S. Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY
		Number	Kind Code <sup>2</sup> (if known)		
CC	P1	3,473,154		Couleur et al.	10/14/1969
CC	P2	3,585,599		Hitt	06/15/1971
CC	P3	3,681,534		Burian et al.	08/01/1972
CC	P4	3,702,989		Provenzano, Jr. et al.	11/14/1972
CC	P5	3,704,363		Salmassy et al.	11/28/1972
CC	P6	3,707,725		Dellheim	12/26/1972
CC	P7	3,771,131		Ling	11/06/1973
CC	P8	3,794,831		Frankeny et al.	02/26/1974
CC	P9	3,805,038		Buedel et al.	04/16/1974
CC	P10	3,906,454		Martin	09/16/1975
CC	P11	4,205,370		Hirtle	05/27/1980
CC	P12	4,293,925		Hang et al.	10/06/1981
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CC	P28	5,404,470		Miyake	04/04/1995
CC	P29	5,434,622		Lim	07/18/1995
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CC	P35	5,689,636		Kleber et al.	11/18/1997
CC	P36	5,689,694		Funyu	11/18/1997
CC	P37	5,715,435		Ikei	02/03/1998
CC	P38	5,748,904		Huang et al.	05/05/1998
CC	P39	5,751,942		Christensen et al.	05/12/1998
CC	P40	5,812,868		Moyer et al.	09/22/1998
CC	P41	5,832,515		Ledoux et al.	11/03/1998
CC	P42	5,878,208		Levine et al.	03/02/1999
CC	P43	5,946,486		Pekowski	08/31/1999
CC	P44	6,009,270		Mann	12/28/1999

<sup>1</sup> Unique citation designation number.

<sup>2</sup> See attached Kinds of U.S. Patent Documents.

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✓	P45	6,012,085	Yohe et al.	01/04/2000
✓	P46	6,106,573	Mahalingaiah et al.	08/22/2000
✓	P47	6,282,701	Wygodny et al.	08/28/2001
✓	P48	6,314,530	Mann	11/06/2001
✓	P49	6,338,159	Alexander	01/08/2002
✓	P50	6,457,144	Eberhard	09/24/2002
✓	P51	6,467,083	Yamashita	10/15/2002
✓	P52	6,487,715	Chamdani et al.	11/26/2002
✓	P53	6,530,076	Ryan et al.	03/04/2003
✓	P54	6,615,370	Edwards et al.	09/02/2003
✓	P55	6,615,371	McCullough et al.	09/02/2003
✓	P56	6,658,649	Bates et al.	12/02/2003
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✓	P58	2001/0054175	Watanabe	12/20/2001
✓	P59	2002/0046393	Leino et al.	04/18/2002
✓	P60	2002/0147965	Swaine et al.	10/10/2002

## FOREIGN PATENT DOCUMENTS

Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document			Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	T <sup>4</sup>
		Office <sup>1</sup>	Number <sup>2</sup>	Kind Code <sup>3</sup> (if known)			
✓	F1	GB	2 329 048		ARM Limited	10/03/1999	
✓	F2	GB	2 329 049		ARM Limited	10/03/1999	

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<sup>1</sup> Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3).

<sup>2</sup> For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document.

<sup>3</sup> Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible.

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